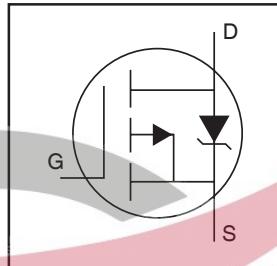


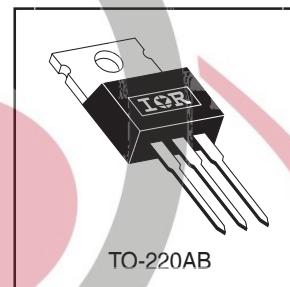
International I²R Rectifier

PD - 94816

IRF4905PbF

HEXFET® Power MOSFET

	$V_{DSS} = -55V$
	$R_{DS(on)} = 0.02\Omega$
	$I_D = -74A$



- Advanced Process Technology
- Ultra Low On-Resistance
- Dynamic dv/dt Rating
- 175°C Operating Temperature
- Fast Switching
- P-Channel
- Fully Avalanche Rated
- Lead-Free

Description

Fifth Generation HEXFETs from International Rectifier utilize advanced processing techniques to achieve extremely low on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET Power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in a wide variety of applications.

The TO-220 package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 watts. The low thermal resistance and low package cost of the TO-220 contribute to its wide acceptance throughout the industry.

Absolute Maximum Ratings

	Parameter	Max.	Units
$I_D @ T_C = 25^\circ C$	Continuous Drain Current, $V_{GS} @ -10V$	-74	
$I_D @ T_C = 100^\circ C$	Continuous Drain Current, $V_{GS} @ -10V$	-52	A
I_{DM}	Pulsed Drain Current ①	-260	
$P_D @ T_C = 25^\circ C$	Power Dissipation	200	W
	Linear Derating Factor	1.3	W/C
V_{GS}	Gate-to-Source Voltage	± 20	V
E_{AS}	Single Pulse Avalanche Energy ②	930	mJ
I_{AR}	Avalanche Current ③	-38	A
E_{AR}	Repetitive Avalanche Energy ④	20	mJ
dv/dt	Peak Diode Recovery dv/dt ⑤	-5.0	V/ns
T_J	Operating Junction and		
T_{STG}	Storage Temperature Range	-55 to + 175	°C
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)	
	Mounting torque, 6-32 or M3 screw	10 lbf·in (1.1 N·m)	

Thermal Resistance

	Parameter	Typ.	Max.	Units
$R_{θJC}$	Junction-to-Case	—	0.75	°C/W
$R_{θCS}$	Case-to-Sink, Flat, Greased Surface	0.50	—	
$R_{θJA}$	Junction-to-Ambient	—	62	

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Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(\text{BR})\text{DSS}}$	Drain-to-Source Breakdown Voltage	-55	—	—	V	$V_{\text{GS}} = 0\text{V}$, $I_D = -250\mu\text{A}$
$\Delta V_{(\text{BR})\text{DSS}/\Delta T_J}$	Breakdown Voltage Temp. Coefficient	—	-0.05	—	V°C	Reference to 25°C , $I_D = -1\text{mA}$
$R_{\text{DS}(\text{on})}$	Static Drain-to-Source On-Resistance	—	—	0.02	Ω	$V_{\text{GS}} = -10\text{V}$, $I_D = -38\text{A}$ ④
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	-2.0	—	-4.0	V	$V_{\text{DS}} = V_{\text{GS}}$, $I_D = -250\mu\text{A}$
g_{fs}	Forward Transconductance	21	—	—	S	$V_{\text{DS}} = -25\text{V}$, $I_D = -38\text{A}$
I_{DSS}	Drain-to-Source Leakage Current	—	—	-25	μA	$V_{\text{DS}} = -55\text{V}$, $V_{\text{GS}} = 0\text{V}$
		—	—	-250		$V_{\text{DS}} = -44\text{V}$, $V_{\text{GS}} = 0\text{V}$, $T_J = 150^\circ\text{C}$
I_{GSS}	Gate-to-Source Forward Leakage	—	—	100	nA	$V_{\text{GS}} = 20\text{V}$
	Gate-to-Source Reverse Leakage	—	—	-100		$V_{\text{GS}} = -20\text{V}$
Q_g	Total Gate Charge	—	—	180	nC	$I_D = -38\text{A}$
Q_{gs}	Gate-to-Source Charge	—	—	32		$V_{\text{DS}} = -44\text{V}$
Q_{gd}	Gate-to-Drain ("Miller") Charge	—	—	86		$V_{\text{GS}} = -10\text{V}$, See Fig. 6 and 13 ④
$t_{\text{d}(\text{on})}$	Turn-On Delay Time	—	18	—	ns	$V_{\text{DD}} = -28\text{V}$
t_r	Rise Time	—	99	—		$I_D = -38\text{A}$
$t_{\text{d}(\text{off})}$	Turn-Off Delay Time	—	61	—		$R_G = 2.5\Omega$
t_f	Fall Time	—	96	—		$R_D = 0.72\Omega$, See Fig. 10 ④
L_D	Internal Drain Inductance	—	4.5	—	nH	Between lead, 6mm (0.25in.) from package and center of die contact
L_S	Internal Source Inductance	—	7.5	—		
C_{iss}	Input Capacitance	—	3400	—		$V_{\text{GS}} = 0\text{V}$
C_{oss}	Output Capacitance	—	1400	—	pF	$V_{\text{DS}} = -25\text{V}$
C_{rss}	Reverse Transfer Capacitance	—	640	—		$f = 1.0\text{MHz}$, See Fig. 5

Source-Drain Ratings and Characteristics

	Parameter	Min.	Typ.	Max.	Units	Conditions
I_S	Continuous Source Current (Body Diode)	—	—	-74	A	MOSFET symbol showing the integral reverse p-n junction diode.
I_{SM}	Pulsed Source Current (Body Diode) ①	—	—	-260	A	
V_{SD}	Diode Forward Voltage	—	—	-1.6	V	$T_J = 25^\circ\text{C}$, $I_S = -38\text{A}$, $V_{\text{GS}} = 0\text{V}$ ④
t_{rr}	Reverse Recovery Time	—	89	130	ns	$T_J = 25^\circ\text{C}$, $I_F = -38\text{A}$
Q_{rr}	Reverse Recovery Charge	—	230	350	nC	$dI/dt = -100\text{A}/\mu\text{s}$ ④
t_{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by L_S+L_D)				

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- ② Starting $T_J = 25^\circ\text{C}$, $L = 1.3\text{mH}$
 $R_G = 25\Omega$, $I_{AS} = -38\text{A}$. (See Figure 12)
- ③ $I_{SD} \leq -38\text{A}$, $dI/dt \leq -270\text{A}/\mu\text{s}$, $V_{\text{DD}} \leq V_{(\text{BR})\text{DSS}}$,
 $T_J \leq 175^\circ\text{C}$
- ④ Pulse width $\leq 300\mu\text{s}$; duty cycle $\leq 2\%$.

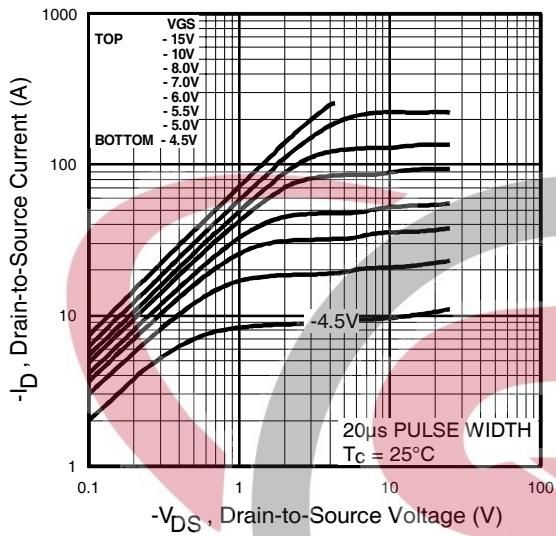


Fig 1. Typical Output Characteristics

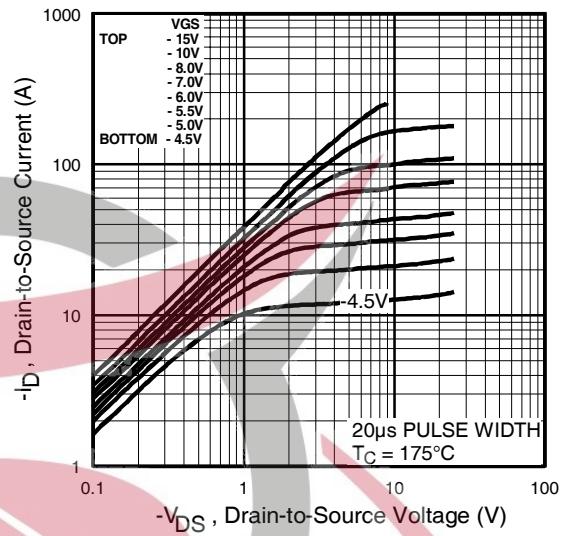


Fig 2. Typical Output Characteristics

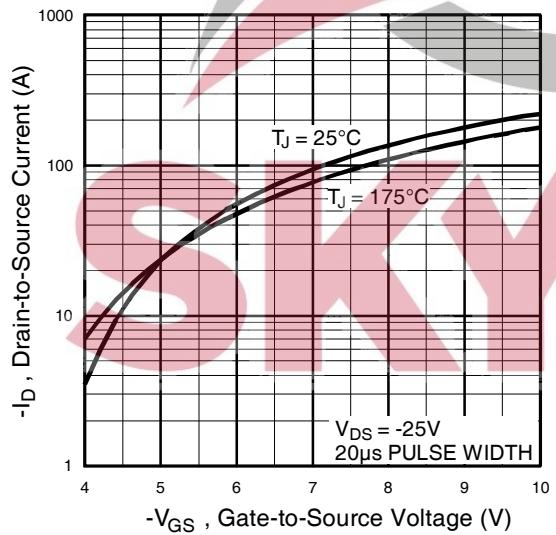


Fig 3. Typical Transfer Characteristics

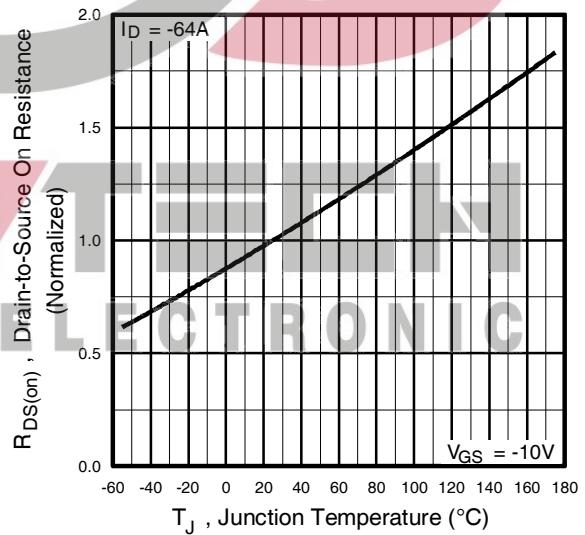


Fig 4. Normalized On-Resistance
Vs. Temperature

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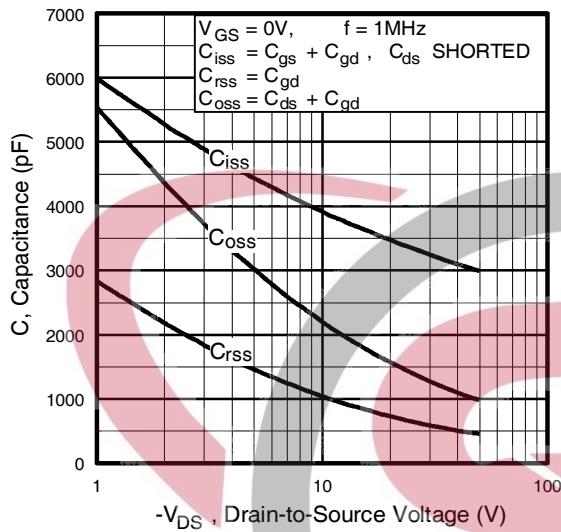


Fig 5. Typical Capacitance Vs.
Drain-to-Source Voltage

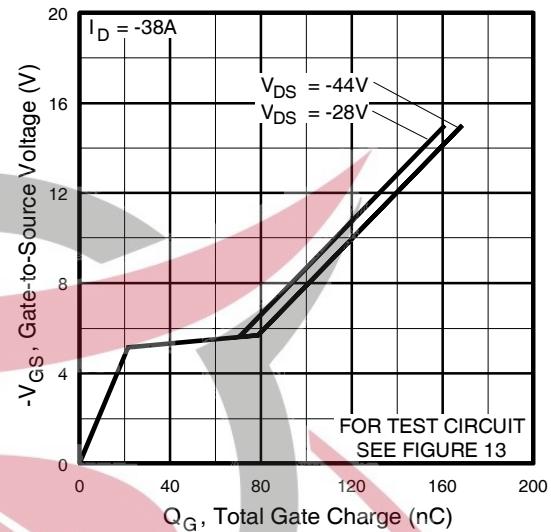


Fig 6. Typical Gate Charge Vs.
Gate-to-Source Voltage

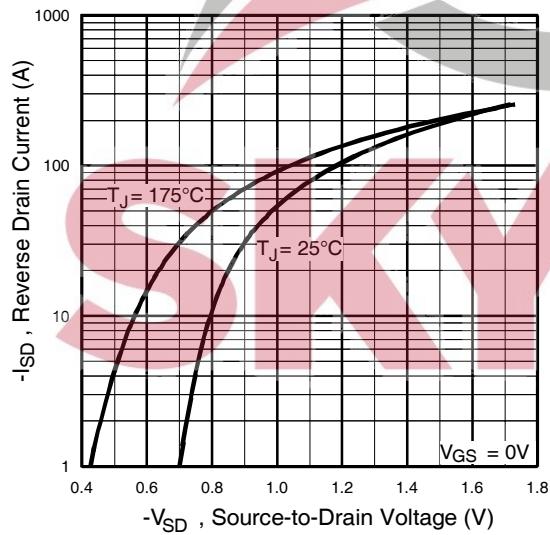


Fig 7. Typical Source-Drain Diode
Forward Voltage

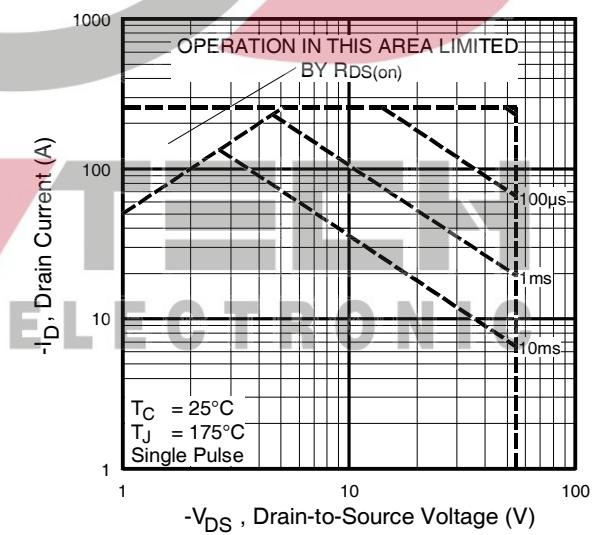


Fig 8. Maximum Safe Operating Area

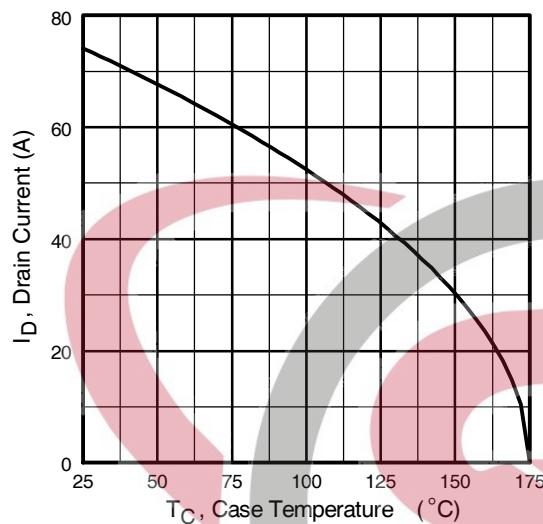


Fig 9. Maximum Drain Current Vs.
Case Temperature

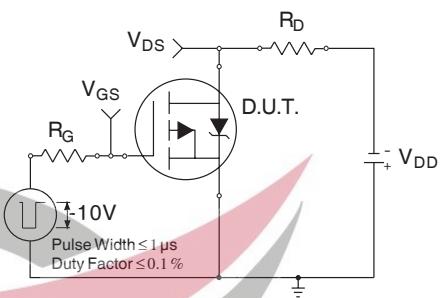


Fig 10a. Switching Time Test Circuit

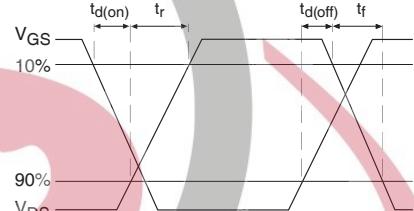


Fig 10b. Switching Time Waveforms

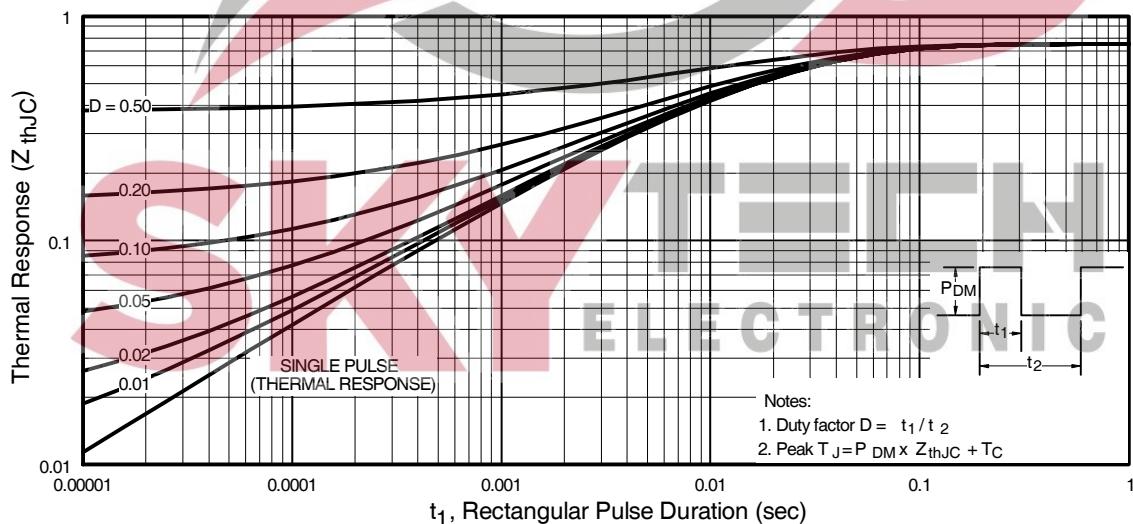


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

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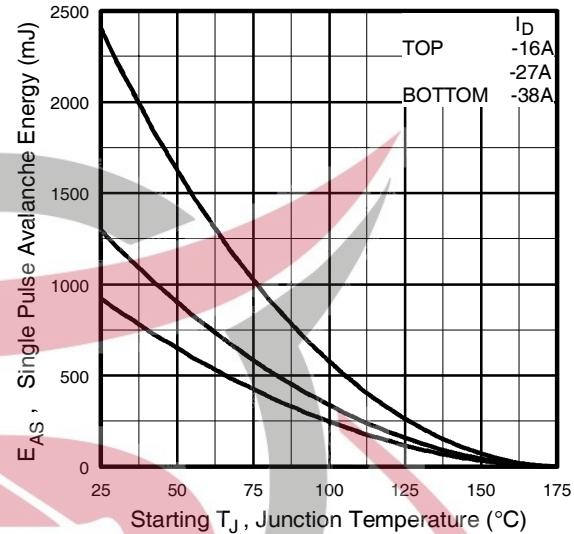
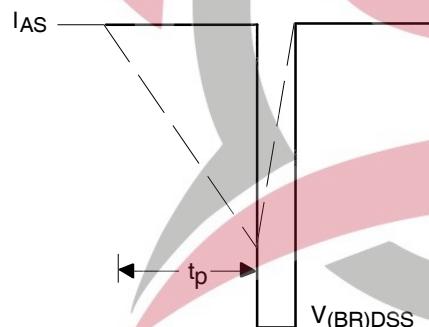
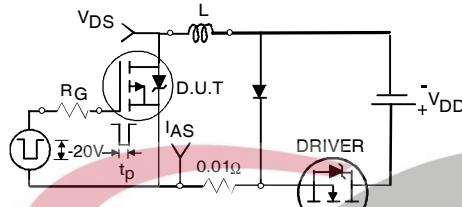


Fig 12a. Unclamped Inductive Test Circuit

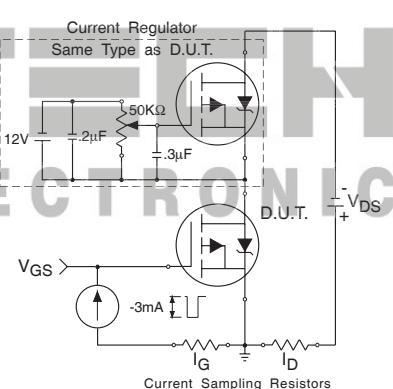
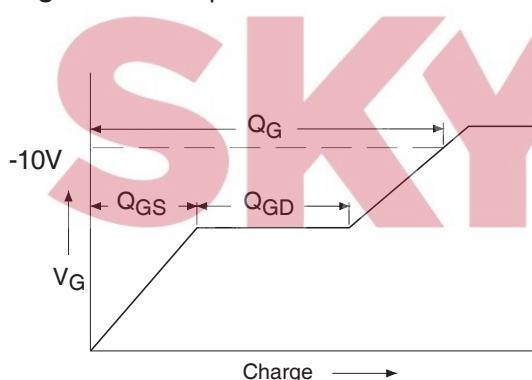
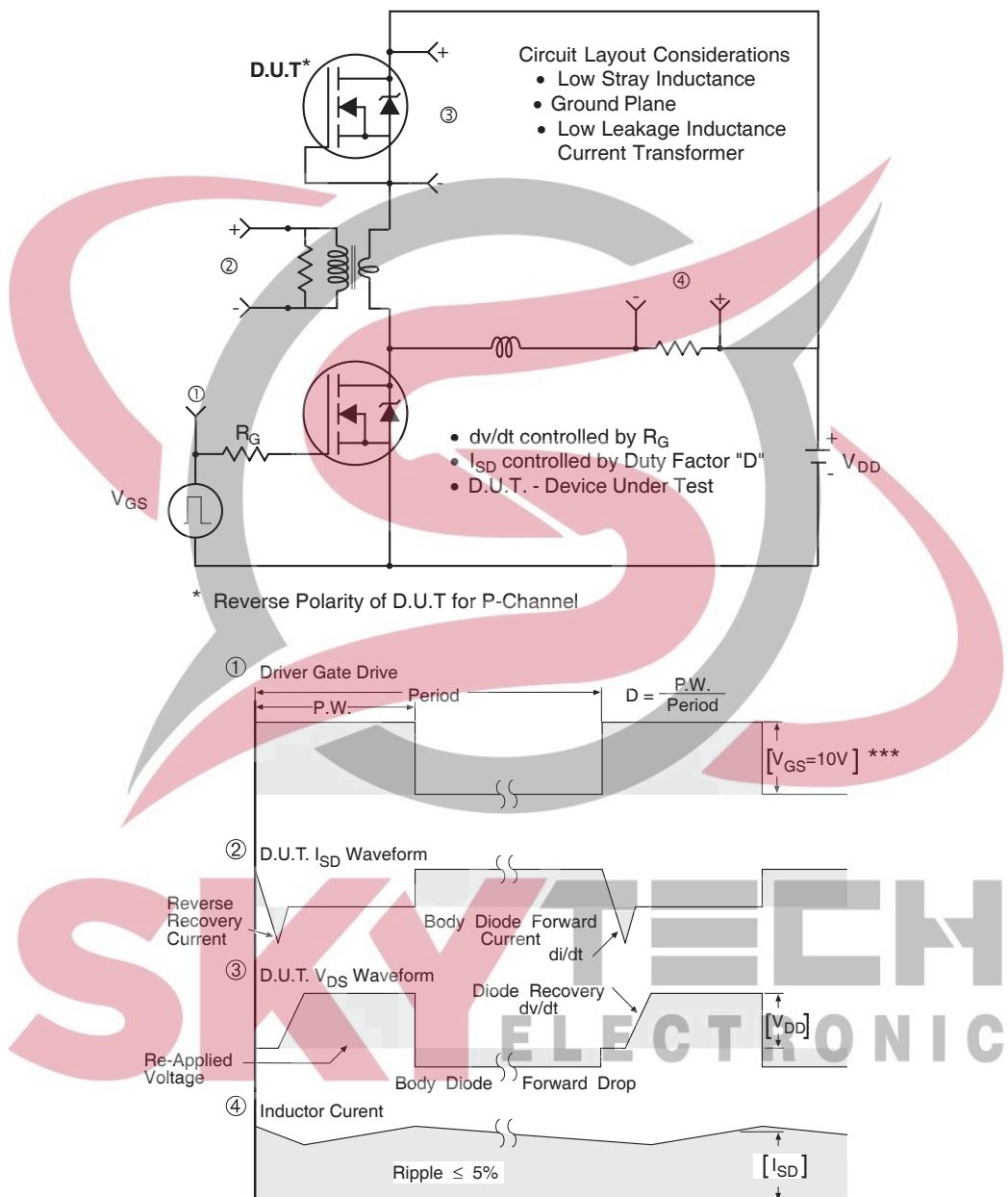


Fig 13a. Basic Gate Charge Waveform

Fig 13b. Gate Charge Test Circuit

Peak Diode Recovery dv/dt Test Circuit

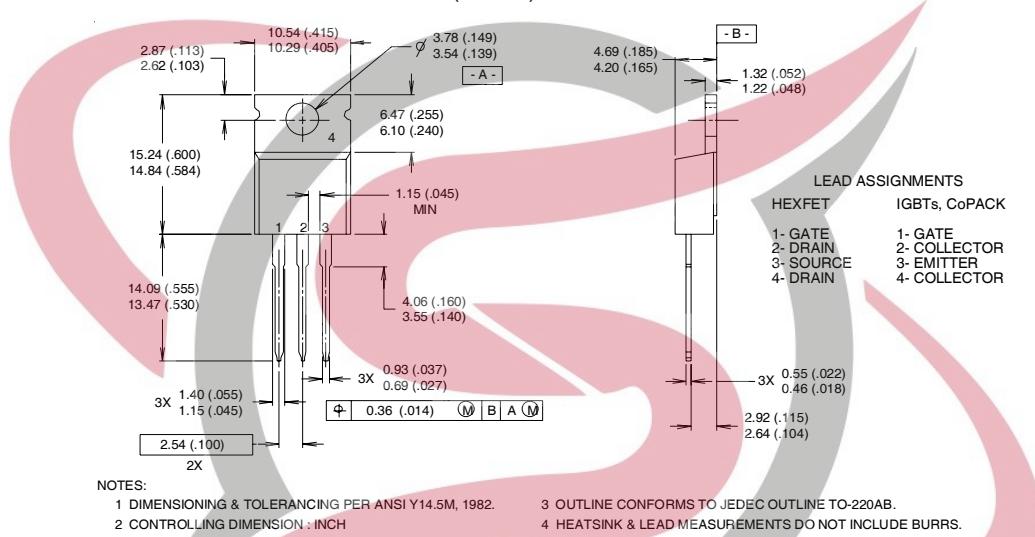


*** $V_{GS} = 5.0V$ for Logic Level and 3V Drive Devices

Fig 14. For P-Channel HEXFETS

TO-220AB Package Outline

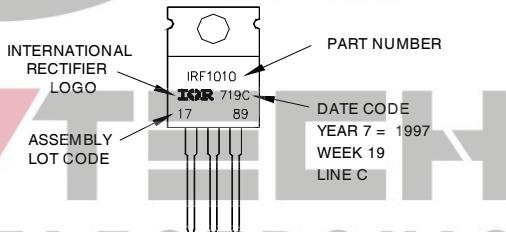
Dimensions are shown in millimeters (inches)



TO-220AB Part Marking Information

EXAMPLE: THIS IS AN IRF1010
LOT CODE 1789
ASSEMBLED ON WW 19, 1997
IN THE ASSEMBLY LINE "C"

Note: "P" in assembly line position indicates "Lead-Free"



Data and specifications subject to change without notice.

International
IR Rectifier

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Note: For the most current drawings please refer to the IR website at:
<http://www.irf.com/package/>

